

# **Analog Peripherals**

# Two Comparators

- Programmable hysteresis and response time
- Configurable to generate interrupts or reset
- Low current

## **On-Chip Debug**

- On-chip debug circuitry facilitates full speed, non-intrusive in-system debug (no emulator required)
- Provides breakpoints, single stepping, watchpoints
- Inspect/modify memory, registers, and stack
- Superior performance to emulation systems using ICE-chips, target pods, and sockets

### Supply Voltage: 2.7 to 3.6 V

## Temperature Range: -40 to +85 °C

### High-Speed 8051 µC Core

Pipelined instruction architecture; executes 70% of instructions in 1 or 2 system clocks

051F365

- Up to 100 MIPS throughput with 100 MHz system clock
- 16 x 16 multiply/accumulate engine (2-cycle)

#### Memory

- 1280 bytes data RAM
- 32 kB Flash; in-system programmable in 512 byte sectors (512 bytes are reserved)

## **Digital Peripherals**

- 24 port I/O; all are 5 V tolerant
- Hardware SMBus<sup>™</sup> (I2C<sup>™</sup> compatible), SPI<sup>™</sup>, and UART serial ports available concurrently
- Programmable 16-bit counter/timer array with six capture/compare modules, WDT
- 4 general-purpose 16-bit counter/timers
- Real-time clock mode using PCA or timer and external clock source

## **Clock Sources**

- Two internal oscillators:
  - 24.5 MHz, 2% accuracy supports UART operation- 80 kHz low frequency, low-power
- External oscillator: Crystal, RC, C, or Clock (1 or 2 pin modes)
- On-Chip programmable PLL: up to 100 MHz

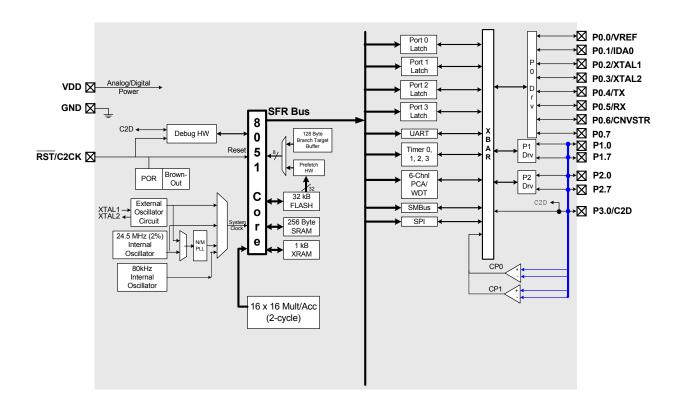
#### Package

#### - 28-pin QFN

- Pin compatible with C8051F311

### **Ordering Part Number**

- C8051F365-GM



**Small Form Factor** 



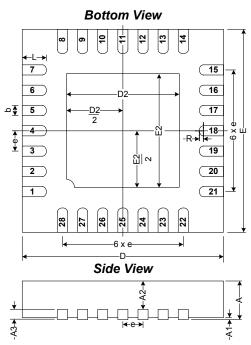
100 MIPS, 16x16 MAC, 32 kB Flash, Mixed-Signal MCU

# **Selected Electrical Specifications**

 $(T_A = -40 \text{ to } +85 \text{ C}^\circ, \text{VDD} = 2.7 \text{ V}$  unless otherwise specified)

Parameter	Conditions	Min	Тур	Max	Units
-	Global Characteristics		I		
Supply Voltage		2.7	—	3.6	V
	Clock = 100 MHz	_	TBD	_	mA
Supply Current with	Clock = 25 MHz	—	TBD	_	mA
CPU active	Clock = 1 MHz	_	TBD	—	μA
	Clock = 80 kHz; $V_{DD}$ Monitor Disabled Clock = 32 kHz; $V_{DD}$ Monitor Disabled	—	TBD	—	μA
Supply Current (shutdown)	Oscillator off; V <sub>DD</sub> Monitor Disabled	_	<0.1	—	μA
Clock Frequency Range		DC	—	100	MHz
	Internal Oscillators				
Frequency (OSC0)		24.0	24.5	25.0	MHz
Frequency (OSC1)	OSC1 can be calibrated in 2.5% steps using an internal calibration register.	_	80	_	kHz
	Comparator				
Response Time Mode0	(CP+) – (CP-) = 100 mV	-	100	_	ns
Current Consumption Mode0		_	TBD	_	μA
Response Time Mode1	(CP+) – (CP-) = 100 mV	_	175	_	ns
Current Consumption Mode1		_	TBD	—	μA
Response Time Mode2	(CP+) – (CP-) = 100 mV	—	320	—	ns
Current Consumption Mode2		—	TBD	—	μA
Response Time Mode3	(CP+) – (CP-) = 100 mV	_	1050	_	ns
Current Consumption Mode3		-	TBD	_	μA

# **Package Information**



# C8051F360DK Development Kit



Small Form Factor
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